## Applicant(s)/Patent Under Application/Control No. Reexamination 10/736,082 CHEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3766 Kristen Mullen **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 424/426 \* 06-2004 Sano et al. US-6,756,048 427/2.21 \* 11-1998 Ding et al. US-5,837,313 В 607/116 US-4,819,662 04-1989 Heil et al. С 607/127 \* 04-1989 Heil et al. US-4,819,661 D. Ε US-US-F US-G US-Н US-1 US-J US-K US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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